



# FCT-650SE: Light I-V and Suns-Voc on Alternative Material Devices



The removable chuck plate allows the tester to be rapidly reconfigured for different sample types.

Light I-V and Suns-Voc measurements for perovskite, silicon, and tandem devices. Sinton Instruments' advanced characterization techniques in combination with a fully programmable steady-state LED light source.

#### **Product Overview**

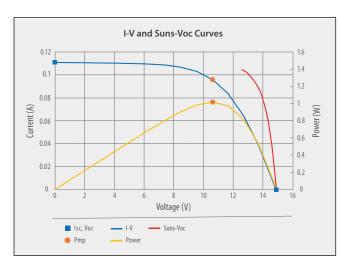
The FCT-650SE measurement system is a versatile, steady-state LED I-V tester designed for perovskite on silicon tandem devices. Combining Sinton Instruments' advanced cell characterization techniques with the Sunbrick® Class AAA LED solar simulator by G2V Optics, it reports I-V and Suns-Voc parameters for silicon, perovskite, and tandem devices, as well as substrate doping and lifetime for silicon. Light soaking, maximum power point tracking, and automated measurement sequences are also supported.

#### System Capabilities

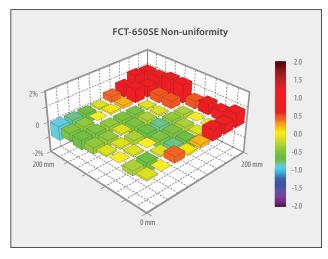
Measure I-V and Suns-Voc for perovskite on silicon tandem cells, silicon cells, or encapsulated minimodules.

System capabilities:

- All materials: Isc, Voc, power, Vmp, Imp, FF, efficiency, Rs, Rsh, and Suns-Voc
- Advanced results, silicon only: bulk lifetime, lifetime at max power, J<sub>0s</sub>, substrate doping and thickness, power loss analysis
- EL imaging (optional)
- I-V sweep with adjustable speed and direction
- Customizable automated measurement sequences
- Light soaking and maximum power point tracking



Example Suns-Voc and I-V data for an encapsulated perovskite device, measured on the FCT-650SE I-V cell tester.



The non-uniformity of the FCT-650SE is Class A  $(\pm 2\%)$  over 200 mm  $\times$  200 mm.

### **FCT-650SE Specifications**

#### **Instrument Specifications**

#### **Available measurements**

- Voc, Isc, power, Vmp, Imp, FF, efficiency, Rs, and Rsh
- Suns-Voc
- · Forward and reverse dark I-V
- Maximum power point tracking

#### Silicon-only measurements

- J<sub>0s</sub>, bulk lifetime, lifetime at max power
- Substrate doping and thickness
- · Power loss analysis

#### Current and voltage range

- 40 V
- 20 A (silicon)
- 2.4 A (perovskite/tandem)

#### Available temperature range

• 25 ->50°C @ 25°C ambient

#### Illumination

- 0.04 1.12 suns
- Class AAA
- Fully programmable spectrum
- Light soaking

#### Available chuck designs

- Silicon:
  - Standard 6-busbar, front-contact chuck
  - Up to 18 busbars available
  - Custom back-contact chucks available
- Thin-film or tandem: contact Sinton Instruments
- Chuck accommodates sample sizes 2– 210 mm<sup>2</sup>

#### Warranty

1-year limited warranty on all parts and software

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#### **Facility Requirements**

#### Ambient operating temperature

• 20°C-25°C

#### **Power requirements**

- Instrument: 80 W
- · Computer with monitor: 200 W
- · Light source: 625 W
- Vacuum: 370 W

#### Dimensions (L x W x H)

- Base: 70 x 66 x 91 cm
- Light Source: 34 x 44 x 87 cm
- Fully assembled: 70 x 66 x 119 cm

#### Universal mains voltage

• 100-240 VAC 50/60 Hz

#### **Special facilities requirements**

• Vacuum: 4.8 cfm, 29.5 in-Hg

## **System Components**

- FCT-650SE I-V tester, electronic load and current, voltage interconnections
- Sunbrick® Class AAA steady-state LED light source with programmable spectrum and intensity
- EL imaging camera (optional)
- · Vacuum pump (optional)
- Windows PC with installed, configured software and monitor

- Sinton Instruments data acquisition and analysis software package
- Temperature-controlled chuck for cells or encapsulated minimodules
- High-resolution, high-speed data acquisition with simultaneous signal sampling and common-mode rejection

## **Purchasing Information**

For a quote, please contact **quotes@sintoninstruments.com** 

We are happy to accommodate custom requirements. Please inquire about a quote for your specific needs. Quotes are valid for 60 days.

For our full product line, visit our website at: www.sintoninstruments.com





